Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSⅢ)

2SK4034

Switching Regulator, DC-DC Converter Applications Motor Drive Applications

- Low drain-source ON-resistance: RDS (ON) = 4.2 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 110 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = 100 \,\mu\text{A} \,(V_{DS} = 60 \,\text{V})$
- Enhancement mode: $V_{th} = 1.5 \text{ to } 2.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	60	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	75	А	
	Pulse(t ≤ 1 ms) (Note 1)	I _{DP}	300		
Drain power dissipation (Tc = 25°C)		PD	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	322	mJ	
Avalanche current		I _{AR}	75	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55 to 150	°C	

$0.4 \pm 0.1_{1}$ 2.0 1.5 2.0 2.5 1.0±0.2 1.0±0.2 1. GATE 2. SOURCE 1: S1 3. SOURCE 2: S2 4. DRAIN **JEDEC** JEITA

SC-97

2-9F1B

Weight: 0.74 g (typ.)

TOSHIBA

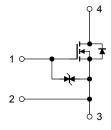
Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to case	R _{th (ch-c)}	1.0	°C/W	

Note: Use the S1 pin to return the gate signal to source. Board traces should be designed so the main current flows to the S2 pin.

- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: $V_{DD} = 25 \text{ V}$, $T_{ch} = 25 ^{\circ}\text{C}$ (initial), $L = 78 \mu\text{H}$, $R_G = 25 \Omega$, $I_{AR} = 75 \text{ A}$
- Note 3: Repetitive rating: pulse width limited by maximum channel temperature
- Note 4: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



This transistor is an electrostatic-sensitive device. Handle with care.

2008-01-15

Electrical Characteristics (Note 5) (Ta = 25°C)

Ch	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-off curi	rent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	_	_	100	μА
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	60	_	_	V
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	35	_	_	V
Gate threshold voltage		V _{th}	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$	1.5	_	2.5	V
Drain-source ON-resistance		D	$V_{GS} = 10 \text{ V}, I_D = 38 \text{ A}$	_	4.2	5.8	mΩ
		R _{DS} (ON)	V _{GS} = 4.5 V, I _D = 38 A	_	5.5	10	mΩ
Forward transfer admittance		Y _{fs}	V _{DS} = 10 V, I _D = 38 A	55	110	_	S
Input capacitance		C _{iss}		_	12400	_	pF
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	410	_	
Output capacitance		Coss		_	1100	_	
Switching time	Rise time	t _r	ADD = 38 V ADD = 30A ADD = 30A ADD = 30A	_	15	_	- ns
	Turn-on time	ton		_	35	_	
	Fall time	t _f		_	45	_	
	Turn-off time	t _{off}	Duty ≤ 1%, t _w = 10 μs	_	250	_	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ 48 V, V _{GS} = 10 V,	_	196	_	nC
Gate-source charge		Qgs	$I_D = 75 \text{ A}$		148	_	
Gate-drain ("miller") charge		Q _{gd}		_	48	_	

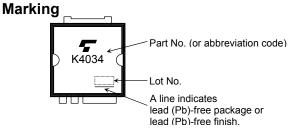
Note 5: The S1 and S2 pins should be grounded together, except when measuring the switching time.

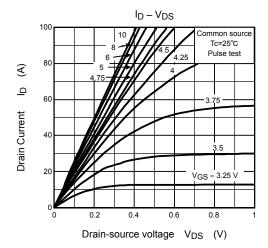
Source-Drain Ratings and Characteristics (Note 6) (Ta = 25°C)

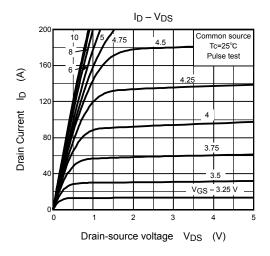
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1, Note 6)	I _{DR} 1	_	_	_	75	Α
Pulse drain reverse current (Note 1, Note 6)	I _{DRP} 1	_	_	_	300	Α
Continuous drain reverse current (Note 1, Note 6)	I _{DR} 2	_	_	_	1	Α
Pulse drain reverse current (Note 1, Note 6)	I _{DRP} 2	_	_	_	4	Α
Forward voltage (diode)	V _{DS2F}	I _{DR1} = 75 A, V _{GS} = 0 V	_	_	-1.5	V
Reverse recovery time	t _{rr}	$I_{DR} = 75 \text{ A}, V_{GS} = 0 \text{ V},$ $dI_{DR}/dt = 50 \text{ A}/\mu\text{s}$	_	70	_	ns
Reverse recovery charge	Q _{rr}		_	77	_	nC

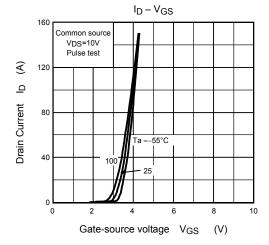
Note 6: $I_{DR}1$, $I_{DRP}1$: Current flowing between the drain and S2 pins. Ensure that the S1 pin is left open. $I_{DR}2$, $I_{DRP}2$: Current flowing between the drain and S1 pins. Ensure that the S2 pin is left open.

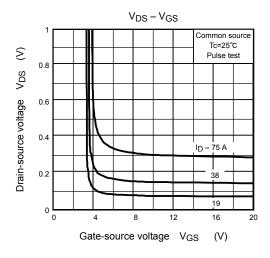
The S1 and S2 pins should be grounded together, unless otherwise noted.

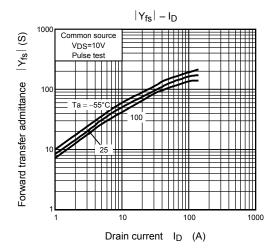


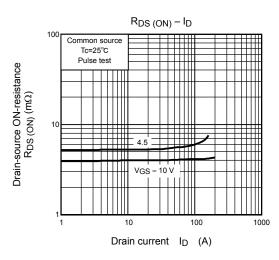


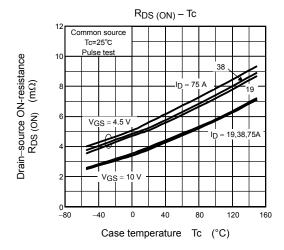


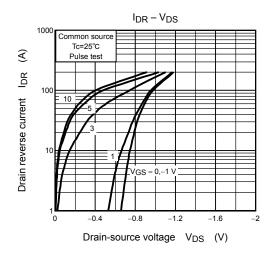


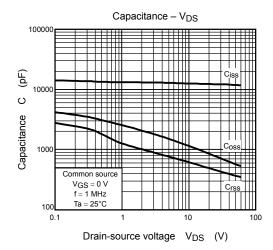


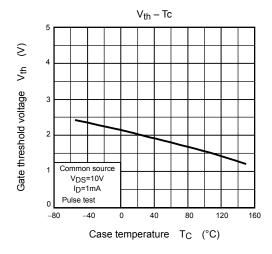


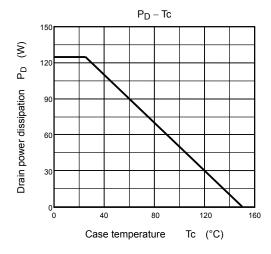


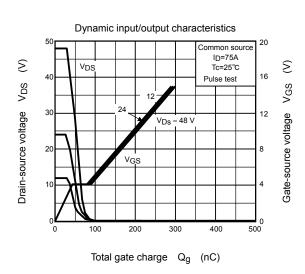


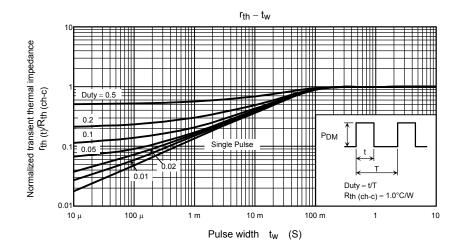


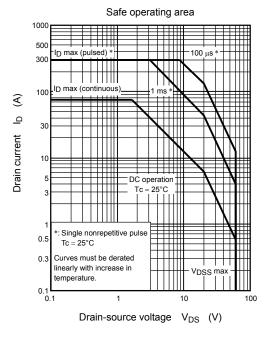


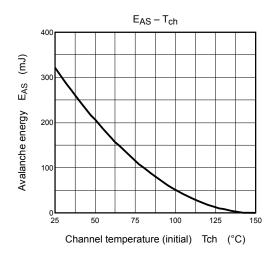


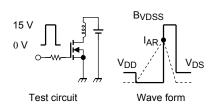












$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 25~V,~L = 78~\mu H \end{aligned}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

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